- 3-State Outputs Drive Bus Lines or Buffer Memory Address Registers
- Package Options Include Plastic Small-Outline (SOIC) and Shrink Small-Outline (SSOP) Packages, Ceramic Chip Carriers, and Plastic and Ceramic DIPs

## description

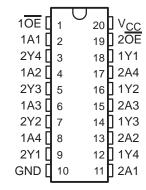
These octal buffers and line drivers are designed specifically to improve both the performance and density of 3-state memory address drivers, clock drivers, and bus-oriented receivers and transmitters. Taken together with the 'F241 and 'F244, these devices provide the choice of selected combinations of inverting and noninverting outputs, symmetrical  $\overline{OE}$  (active-low output-enable) inputs, and complementary  $\overline{OE}$  and  $\overline{OE}$  inputs.

The 'F240 is organized as two 4-bit buffers/line drivers with separate output enable  $(\overline{OE})$  inputs. When  $\overline{OE}$  is low, the device passes data from the A inputs to the Y outputs. When  $\overline{OE}$  is high, the outputs are in the high-impedance state.

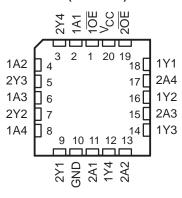
The SN74F240 is available in Tl's shrink small-outline package (DB), which provides the same I/O pin count and functionality of standard small-outline packages in less than half the printed-circuit-board area.

The SN54F240 is characterized for operation over the full military temperature range of  $-55^{\circ}$ C to 125°C. The SN74F240 is characterized for operation from 0°C to 70°C.

### SN54F240 . . . J PACKAGE SN74F240 . . . DB, DW, OR N PACKAGE (TOP VIEW)



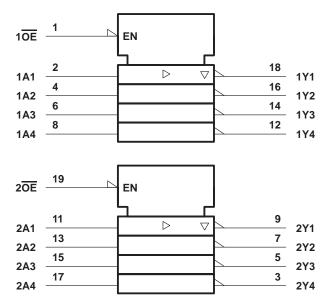
## SN54F240 . . . FK PACKAGE (TOP VIEW)



FUNCTION TABLE (each buffer)

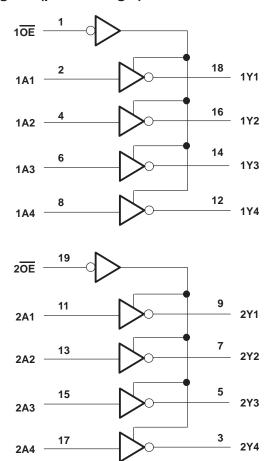
INPU	JTS	OUTPUT
OE	Α	Υ
L	Н	L
L	L	Н
Н	Χ	Z

## logic symbol†



<sup>†</sup> This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12.

## logic diagram (positive logic)



## absolute maximum ratings over operating free-air temperature range (unless otherwise noted)‡

, , ,		
Voltage range applied to any output in	the disabled or power-off state	0.5 V to 5.5 V
Voltage range applied to any output in	the high state	$\dots$ -0.5 V to V <sub>CC</sub>
Current into any output in the low state	:: SN54F240	96 mA
	SN74F240	128 mA
Operating free-air temperature range:	SN54F240	. −55°C to 125°C
	SN74F240	0°C to 70°C
Storage temperature range		. −65°C to 150°C

<sup>‡</sup> Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTE 1: The input voltage ratings may be exceeded provided the input current ratings are observed.



## recommended operating conditions

		SN54F240			SN74F240			UNIT
		MIN	NOM	MAX	MIN	NOM	MAX	UNIT
Vcc	Supply voltage	4.5	5	5.5	4.5	5	5.5	V
VIH	High-level input voltage	2			2			V
V <sub>IL</sub>	Low-level input voltage			0.8			0.8	V
liK	Input clamp current			-18			-18	mA
IOH	High-level output current	- 12				<b>–</b> 15	mA	
loL	Low-level output current			48			64	mA
TA	Operating free-air temperature	-55		125	0		70	°C

# electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST CONDITIONS		S	SN54F240			SN74F240		
			MIN	TYP†	MAX	MIN	TYP†	MAX	UNIT
VIK	V <sub>CC</sub> = 4.5 V,	$I_{I} = -18 \text{ mA}$			-1.2			-1.2	V
		$I_{OH} = -3 \text{ mA}$	2.4	3.3		2.4	3.3		
Vari	V <sub>CC</sub> = 4.5 V	$I_{OH} = -12 \text{ mA}$	2	3.2					V
VOH		$I_{OH} = -15 \text{ mA}$				2	3.1		
	$V_{CC} = 4.75 \text{ V},$	$I_{OH} = -3 \text{ mA}$				2.7			
V	V <sub>CC</sub> = 4.5 V	$I_{OL} = 48 \text{ mA}$		0.38	0.55				V
V <sub>OL</sub>		$I_{OL} = 64 \text{ mA}$					0.42	0.55	
lozh	$V_{CC} = 5.5 \text{ V},$	$V_0 = 2.7 \text{ V}$			50			50	μΑ
lozL	V <sub>CC</sub> = 5.5 V,	V <sub>O</sub> = 0.5 V			-50			-50	μΑ
lį	V <sub>CC</sub> = 5.5 V,	V <sub>I</sub> = 7 V			0.1			0.1	mA
lін	V <sub>CC</sub> = 5.5 V,	V <sub>I</sub> = 2.7 V			20			20	μΑ
IIL	V <sub>CC</sub> = 5.5 V,	V <sub>I</sub> = 0.5 V			<b>–</b> 1			<b>–</b> 1	mA
los <sup>‡</sup>	V <sub>CC</sub> = 5.5 V,	V <sub>O</sub> = 0	-100		-225	-100		-225	mA
	V <sub>CC</sub> = 5.5 V	Outputs high		19	29		19	29	
ICC		Outputs low		50	75		50	75	mA
		Outputs disabled		42	63		42	63	]

<sup>†</sup> All typical values are at V<sub>CC</sub> = 5 V, T<sub>A</sub> = 25°C. ‡ Not more than one output should be shorted at a time, and the duration of the short circuit should not exceed one second.

## switching characteristics (see Note 2)

PARAMETER	FROM TO (INPUT)		$V_{CC}$ = 5 V, $C_{L}$ = 50 pF, $R_{L}$ = 500 Ω, $T_{A}$ = 25°C			$V_{CC}$ = 4.5 V to 5.5 V, $C_L$ = 50 pF, $R_L$ = 500 $\Omega$ , $T_A$ = MIN to MAX $^{\dagger}$				UNIT
			′F240		SN54F240		SN74F240			
			MIN	TYP	MAX	MIN	MAX	MIN	MAX	
<sup>t</sup> PLH	Any A	Y	2.2	4.7	7	2.2	9	2.2	8	ns
<sup>t</sup> PHL			1.2	3.1	4.7	1.2	6	1.2	5.7	
<sup>t</sup> PZH	ŌĒ	Y	1.2	3.1	5.3	1.2	6.7	1.2	6.1	20
t <sub>PZL</sub>		Y	3.2	6.5	9	3.2	10.5	3.2	10	ns
<sup>t</sup> PHZ	ŌĒ	Y	1.2	3.6	5.3	1.2	6.5	1.2	6.3	ns
t <sub>PLZ</sub>		1	1.2	5.6	8	1.2	12.5	1.2	9.5	115

<sup>†</sup> For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions. NOTE 2: Load circuits and waveforms are shown in Section 1.



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